

Notice of References Cited	Application/Control No. 10/627,727	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Matt P. Hodges	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0075388 A1	04-2004	Miyashita et al.	313/586
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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